

Notice of References Cited

 Application/Control No.
 09/649,122

 Applicant(s)/Patent Under
 Reexamination
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 3626

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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FOREIGN PATENT DOCUMENTS

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	N	JP 08-314727	11-1996	Japan	Tanaka et al.	G06F009/45
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NON-PATENT DOCUMENTS

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